THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No. 09/234,233
Filing Date January 20, 1999
Inventor. Weimin Li, et al
Assignee Micron Technology, Inc.
Group Art Unit. 2818
Examiner D. Le

Attorney's Docket No......Ml22-1035
Title: Semiconductor Processing Methods

## **INFORMATION DISCLOSURE STATEMENT**

References – See Attached Form PTO-1449

In compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the United States patent listed on the attached Form PTO-1449. No admission is made regarding whether all the submitted references are prior art.

This Supplemental Information Disclosure Statement is being filed after the filing of a Request for Continued Examination (RCE) Application and prior to the receipt of the first Office Action. Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Supplemental Information Disclosure Statement, please charge the fee specified under 37 C.F.R. §1.17(p) to Deposit Account No. 23-0925. Please credit Deposit Account No. 23-0925 with any overpayment of the above fee.

Citation of this reference is respectfully requested.

Respectfully submitted,

Dated: O4 Ana

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James E. Lake

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